

## Description

The IRF7313TRPBF uses advanced trench technology

to provide excellent  $R_{\text{DS}(\text{ON})},$  low gate charge and

operation with gate voltages as low as 2.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

## **General Features**

VDS = 30V ID = 8.5 A

 $R_{DS(ON)} < 18m\Omega @ V_{GS}=4.5V$ 

## Application

Battery protection

Load switch

Uninterruptible power supply

## Package Marking and Ordering Information

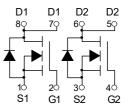
Product ID	Pack	Marking	Qty(PCS)
IRF7313TRPBF	SOP-8	F7313 XXXX	3000

## Absolute Maximum Ratings@T<sub>i</sub>=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	30	V
V <sub>GS</sub>	Gate-Source Voltage	<u>+</u> 20	V
I₀@T₄=25℃	Drain Current, V <sub>GS</sub> @ 4.5V <sup>3</sup>	8.5	А
I <sub>D</sub> @T <sub>A</sub> =70°C	Drain Current, V <sub>GS</sub> @ 4.5V <sup>3</sup>	5.8	A
Ідм	Pulsed Drain Current <sup>1</sup>	37	А
P <sub>D</sub> @T <sub>A</sub> =25℃	Total Power Dissipation	1.5	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction- ambient <sup>3</sup>	85	°C/W



SOP-8



### **Dual N-Channel MOSFET**



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
$BV_{DSS}$	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V	
∆BV <sub>DSS</sub> /∆T <sub>J</sub>	BVDSS Temperature Coefficient	Reference to $25^{\circ}$ C , I <sub>D</sub> =1mA		0.034		V/°C	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =7A		15	18	mΩ	
TOS(ON)	Static Drain-Source On-rresistance	$V_{GS}$ =4.5V , $I_{D}$ =4A		22	28	1115.2	
$V_{GS(th)}$	Gate Threshold Voltage	──V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.2		2.5	V	
	V <sub>GS(th)</sub> Temperature Coefficient	VGS-VDS, ID -2000A		-5.8		mV/°C	
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =24V , $V_{GS}$ =0V , $T_J$ =25°C			1	uA	
IDSS	Dialit-Source Leakage Current	$V_{DS}$ =24V , $V_{GS}$ =0V , $T_J$ =55°C	=0V , TJ=55°C		5	uA	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm 20V$ , $V_{DS}=0V$			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =7A		6		S	
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.5		Ω	
Qg	Total Gate Charge (4.5V)			6			
$Q_{gs}$	Gate-Source Charge	V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =7A		2.5		nC	
$Q_gd$	Gate-Drain Charge			2.1			
T <sub>d(on)</sub>	Turn-On Delay Time			2.4			
Tr	Rise Time	$V_{DD}$ =15V , $V_{GS}$ =10V , $R_G$ =3.3 $\Omega$		7.8		no	
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =7A		22		ns	
T <sub>f</sub>	Fall Time			4			
C <sub>iss</sub>	Input Capacitance			572			
Coss	Output Capacitance	$V_{DS}$ =15V , $V_{GS}$ =0V , f=1MHz		80		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			65			
Is	Continuous Source Current <sup>1,5</sup>				7.3	А	
I <sub>SM</sub>	Pulsed Source Current <sup>2,5</sup>	──V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			37	А	
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}$ =0V , $I_{S}$ =1A , $T_{J}$ =25 $^{\circ}$ C			1.2	V	
t <sub>rr</sub>	Reverse Recovery Time			20		nS	
			<u> </u>				

I⊧=7A , dl/dt=100A/µs , Tյ=25°C

#### al Characteristics (T.=25 $^{\circ}$ C unless otherwise noted) Flectric

Note :

Qrr

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1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%

Reverse Recovery Charge

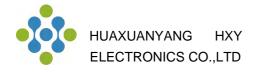
3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH, I<sub>AS</sub>=21A

4. The power dissipation is limited by 150°C junction temperature

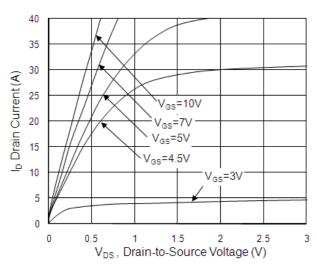
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

nC

1.1



## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

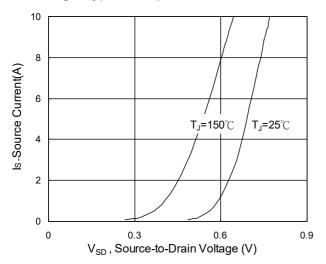


Fig.3 Forward Characteristics Of Reverse

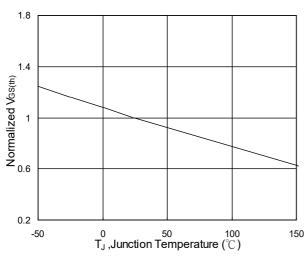


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

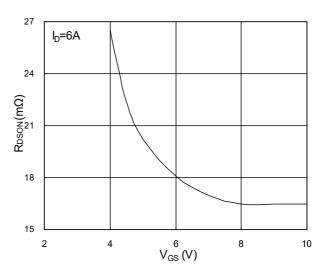


Fig.2 On-Resistance vs. G-S Voltage

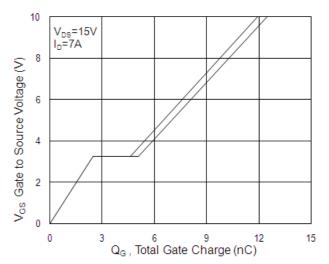


Fig.4 Gate-Charge Characteristics

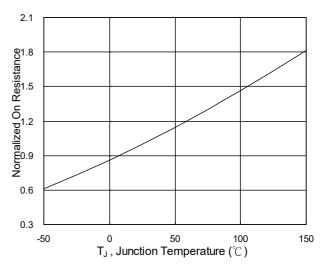
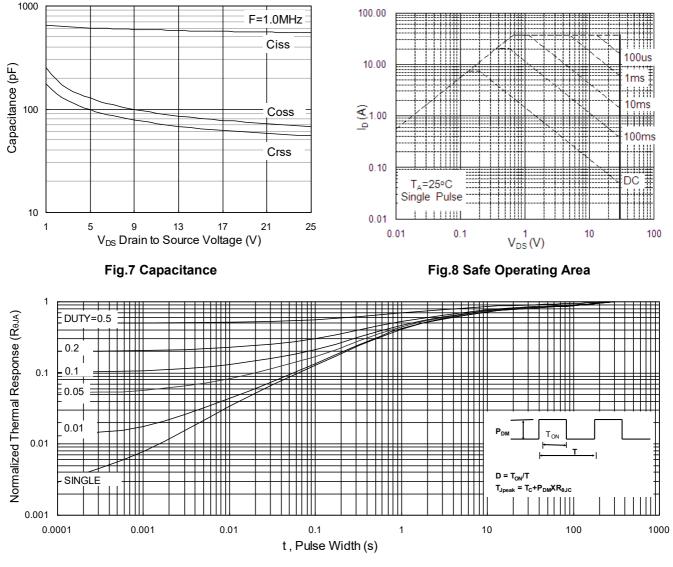


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>







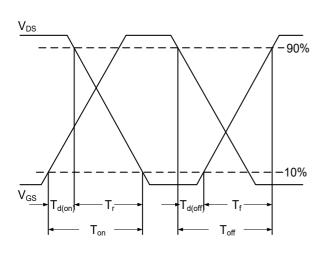


Fig.10 Switching Time Waveform

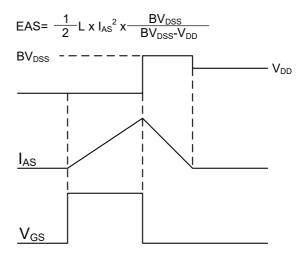
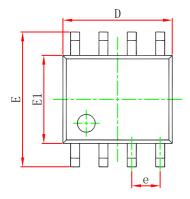
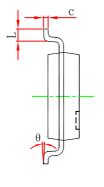


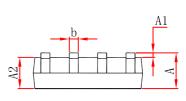
Fig.11 Unclamped Inductive Switching Waveform



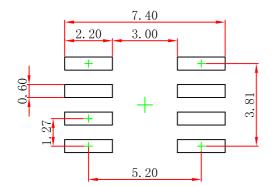
# SOP-8 Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
Α	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
с	0.170	0.250	0.007	0.010
D	4.800	5.000	0.189	0.197
e	1.270 (BSC)		0.050 (BSC)	
E	5.800	6.200	0.228	0.244
E1	3.800	4.000	0.150	0.157
L	0.400	1.270	0.016	0.050
θ	0 °	8°	0 °	8°



Note: 1.Controlling dimension: in millimeters.

2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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